## Applicant(s)/Patent Under Application/Control No. Reexamination 10/645,352 RYPAN, ZENON Notice of References Cited Art Unit Examiner Page 1 of 1 Philip H. Leung 3742 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 219/746 04-1977 US-4,019,009 Kusunoki et al. US-В US-C US-D US-Ε US-F US-G US-Н US-US-US-US-US-FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY 0 Ρ Q R S **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U V W

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